

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10/562,628	WINKLER ET AL.
	Examiner	Art Unit
	DNYANESH KASTURE	3746

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0179233 A1	12-2002	Ruotsalainen, Sami	156/272.8
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2002031088 A	01-2002	Japan	HOSHINA et al.	F04D 29/32
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	English Language Translation of Japanese Patent JP 2002031088 A to Hoshina et al
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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